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X-ray dynamical diffraction in amino acid crystals: a step towards improving structural resolution of biological molecules *via* physical phase measurements¹

Sérgio L. Morelhão,^a* Cláudio M. R. Remédios,^b Guilherme A. Calligaris^c and Gareth Nisbet^d

^aInstituto de Física, Universidade de São Paulo, São Paulo, SP, Brazil, ^bFaculdade de Física, Universidade Federal do Pará, Belém, PA, Brazil, ^cInstitute of Physics Gleb Wataghin, University of Campinas, Campinas, SP, Brazil, and ^dDiamond Light Source, Harwell Science and Innovation Campus, OX11 0DE, UK. *Correspondence e-mail: morelhao@if.usp.br

In this work, experimental and data analysis procedures were developed and applied for studying amino acid crystals by means of X-ray phase measurements. The results clearly demonstrated the sensitivity of invariant triplet phases to electronic charge distribution in D-alanine crystals, providing useful information for molecular dynamics studies of intermolecular forces. The feasibility of using phase measurements to investigate radiation damage mechanisms is also discussed on experimental and theoretical grounds.

1. Introduction

The hydrogen bond is the most important of all directional intermolecular interactions. It is ubiquitous in nature and a critical chemical bond in life science, responsible for the conformational stability of proteins and ensuring their biological functionality (Steiner, 2002; Rossi et al., 2015). Within the current context of experimental and theoretical methods for molecular structure determination there are still many challenges, among them the accurate description of interactions between an electron-deficient hydrogen atom and electronrich atoms (Reichenbächer & Popp, 2012; Tafipolsky, 2016). Particularly in protein X-ray crystallography, the detection of H atoms is one of the major problems, since they display only weak contributions to diffraction data (Ogata et al., 2015). Nuclear methods such as neutron diffraction are sensitive to the proton position and combined with X-ray methods have been able to locate important H atoms to improve our understanding of macromolecular structure and function (Blakeley et al., 2015). However, even in small-molecule crystals, experimental determination of electron charge in hydrogen bonds is a difficult problem, demanding charge density maps with sub-ångström resolution (Gopalan et al., 2000; Krawczuk & Stadnicka, 2012).

Radiation damage in X-ray crystallography is another problem that compromises the resolution of electron density maps as well as the reliability of structure determination in biomolecules and organic samples in the crystalline state (Teng & Moffat, 2000; Blakeley *et al.*, 2015; Gerstel *et al.*, 2015; Garman & Weik, 2017). Despite all the advances in X-ray detectors and data collection protocols, radiation damage still occurs at cryogenic temperatures and the known protein structures suffer, at least to some extent, from inaccuracies originating from this effect (Pozharski *et al.*, 2013). Formation of hydrogen gas in the sample during irradiation, rather than bond cleavage, has been pointed out as the major cause for the loss of high-resolution information (Meents *et al.*, 2010). The largely incomplete understanding of the physical and chemical mechanisms behind structural damage has recently motivated the development of computational tools specifically for investigating damage creation mechanisms (Bernasconi & Brandao-Neto, 2016). In this sense, it is desirable to have an X-ray tool capable of experimentally probing small structural features such as electron charge in hydrogen bonds and radiation damage effects at atomic scales, or simply to validate high-resolution structures obtained from other experimental or purely computational methods.

1.1. Physical phase measurements in X-ray crystallography

From inorganic crystals to protein crystals, structure determination with atomic resolution is mostly based on diffraction techniques (X-rays, neutrons and electrons). However, since the coherent scattering cross sections for X-rays by atoms have intermediate values between those for electrons and neutrons, physical measurements of structure factor phases have been feasible with X-rays only (Amirkhanyan et al., 2014). Dynamical diffraction taking place within perfect domains is another requirement for physical phase measurements via multiple diffraction (MD) experiments. In crystals with small unit cells, the dynamical diffraction regime is achieved in much smaller domains than in crystals with large cells such as protein crystals: a fact that has allowed phase measurements to reveal structural details inaccessible by other techniques - in magnetic materials (Shen et al., 2006) and optical crystals with dopant ions (Morelhão et al., 2011; Amirkhanyan et al., 2014), and to resolve the chirality in crystals with no resonant atoms (Hümmer & Weckert, 1995; Shen *et al.*, 2000; Morelhão *et al.*, 2015).

Excitation of second-order diffractions, MDs for short, and their potential applications in X-ray crystallography have been investigated since Renninger (1937) performed the first azimuthal scanning in the early 20th century, the so-called Renninger scanning. When similar experiments are carried out, very often the intensity profiles exhibit characteristic asymmetries, such as those seen in Fig. 1 (top panel), owing to dynamical coupling of the simultaneously diffracted waves inside a single-crystal domain. Over several decades, these often observed asymmetries have motivated numerous researchers in developing theoretical approaches and experimental procedures to process MD intensity profiles into structural information (Hart & Lang, 1961; Colella, 1974; Post, 1977; Chapman et al., 1981; Juretschke, 1982; Chang, 1997; Weckert & Hümmer, 1997; Chang et al., 1999; Wang et al., 2001; Mo et al., 2002; Morelhão & Kycia, 2002; Shen, 2003).

Nowadays, crystallographic studies are conducted by an increasing number of non-experts owing to substantial instrumental automation and the continuing improvement of software (Pozharski *et al.*, 2013). In this scenario, old phase measurement methods based on dynamical diffraction simulation to obtain triplet phase values within error bars are completely outdated, such that the average number of publications using this technique has dropped to less than one per year since the mid-2000s. Besides the time-consuming nature of the experiments and the need for familiarity with dynamical theory and a high level of instrumental expertise in single-crystal diffraction, the major reason discouraging further exploitation of the technique has been the low accuracy of the obtained phase values, providing no gain in structural resolution (Soares *et al.*, 2003). However, it has been well known



Figure 1

Dynamical diffraction in a D-alanine crystal, giving rise to asymmetric intensity profiles in MD cases (top panel). X-rays of 10 keV, σ polarization. Inset: D-alanine zwitterion. Graphical indexing through Bragg-cone lines (bottom panel) provides a general picture of the nearby cases, their relative strength (line thickness) and the easy distinction of the out–in/in–out geometries (blue/red lines). MD peaks are seen at the intersections of Bragg-cone lines with the 261 one (horizontal dashed line).

for some time that the type of asymmetry, *i.e.* if the MD intensity profile has lower/higher (L|H) or higher/lower (H|L) shoulders, is a reliable source of information even in crystals with some mosaicity (Chang, 1984; Shen & Colella, 1986; Weckert & Hümmer, 1997; Thorkildsen *et al.*, 2003; Morelhão, 2003). Very recently, it has been proposed that this fact leads to a window of accuracy in phase measurements, implying new strategies on how to look at these asymmetries, and opening opportunities for high-resolution studies of crystal structures (Morelhão *et al.*, 2015).

In this work, to demonstrate in practice one such strategy and to highlight its potential in structural biology, we choose the challenge of detecting electron charge in hydrogen bonds responsible for intermolecular forces between amino acid molecules. The strategy is described step by step from experiment planning to data analysis procedures. Easy computer codes are used and no dynamical diffraction simulation is needed. Reliable phase information is identified by a simple graphical indexing (e.g. Fig. 1, bottom panel), which is also very useful for other diffraction techniques in semiconductor devices and single crystals in general (Domagała et al., 2016; Nisbet et al., 2015). Diffraction data from single crystals of D-alanine collected at two synchrotron facilities and with different instrumentation (flux, optics and goniometry) are presented. Model structures taking into account ionic charges are proposed and refined through comparison with experimental data, leading to an ideal model to describe X-ray diffraction by this simple amino acid molecule in terms of triplet phase invariants. According to this model, van der Waals forces between D-alanine zwitterions are also acting in the crystal structure. Moreover, within our data set, we found the first insight on the possibility of using X-ray phase measurements to study radiation damage in crystals.

2. Model structures

With molecular formula $C_3H_7NO_2$, L- and D-alanine are among the smallest amino acid molecules. When grown in



(a), (b) D-Alanine molecule, three-dimensional and flat view. (c) N– H···O bonds (dashed lines) between adjacent molecules in the crystal structure. Orthorhombic unit cell of lattice parameters a = 6.031 (3), b = 12.335 (5), c = 5.781 (3) Å. Twelve N–H···O bonds per unit cell.

aqueous solution, both enantiomers crystallize in space group $P2_12_12_1$ at ambient pressure, with four molecules per unit cell. The intermolecular forces are hydrogen bonds where the amine group (NH³⁺) of each molecule, in its zwitterionic form (Boldyreva, 2007; Moore *et al.*, 2011), makes N-H···O bonds with oxygen atoms of three carboxylate groups (COO⁻) of the nearest molecules (Fig. 2), thus linking the molecules together to form a three-dimensional crystal structure (Degtyarenko *et al.*, 2008; Funnell *et al.*, 2010). Owing to these hydrogen bonds, there is a non-spherosymmetric electron charge distribution around each amine group.

For successful use of phase measurements, the first and fundamental step in any application of this technique is the identification of MD cases susceptible to the specific structural



Figure 3 Comparison of simulated XRD patterns according to NH3 and N3*e* model structures. X-rays of 10 keV, σ polarization.

features under investigation. This is accomplished by elaborating suitable model structures for each particular study. In our example here, we are searching for MD cases suceptible to the non-spherosymmetric electron charge distribution due to hydrogen bonds, and for this goal two simple models are initially used. One is a realistic model, denoted as the NH3 model, where the hydrogen atoms are set around the N atoms at distances of 1.05 ± 0.02 Å (Fig. 2*a*), as determined by neutron diffraction (Lehmann *et al.*, 1972; Wilson *et al.*, 2005). The other is a hypothetical model, denoted as the N3*e* model, where hydrogen electrons are placed in the nitrogen orbitals so that the amine group scatters X-rays as the N³⁻ ion with spherosymmetric charge distribution.

In terms of diffracted intensities, the overall differences can be seen by comparing simulated X-ray powder diffraction patterns for both models (Fig. 3). Tabulated atomic scattering factors for neutral atoms (Brown *et al.*, 2006) were used in calculating diffracted intensities of the NH3 model structure, while the atomic scattering factor of the N³⁻ ion (Morelhão *et al.*, 2015) represents the total scattering of amine groups in the N3*e* model. The comparison in Fig. 3 shows that, to distinguish between these models by such standard X-ray methods, an experimental accuracy of better than 1% (regarding the main peak) in measuring relative intensities of diffraction peaks would be required. For this reason, the realistic model NH3 is based on neutron diffraction data where no information is available on the polarization state of H atoms.

3. Principles of phase measurements

Phase measurements rely on the fact that in a crystal undergoing dynamical diffraction the integrated intensity of one reflection, reflection G, when measured as a function of the excitation of another reflection, reflection H, gives rise to an intensity profile whose asymmetry depends on the triplet phase:

$$\Psi = \delta_H + \delta_{G-H} - \delta_G \tag{1}$$

(e.g. Chang, 1997), where δ_X is the phase of structure factor F_X of reflection X (X = G, H and G–H).

To identify the most susceptible MD cases for studying hydrogen bonds in this amino acid crystal by phase measurements, it is necessary first to search for structure factors with phases susceptible to changes in the models, as done in Fig. 4(*a*). This indicates a few reflections, namely 202, 252 and 261, that are good candidates for phase measurements. Since these reflections have small $|F_G|$ values, *i.e.* are weak reflections, they can only be used as the primary *G* reflection. After selecting the *G* reflection, it is necessary to find secondary *H* reflections that promote MD cases with opposite profile asymmetries for each of the proposed model structures. This can be done by calculating

$$F_H F_{G-H} / F_G = W \exp(i\Psi) \tag{2}$$

for both models and selecting the cases where the phase shift $\Delta \Psi$ is large enough to make the triplet phase pass through the $\pm 90^{\circ}$ values, *i.e.* those cases where $\cos(\Psi)\cos(\Psi + \Delta\Psi) < 1$.

This procedure is illustrated in Fig. 4(b) for 261 as the *G* reflection. It predicts many cases having opposite asymmetries, including the cases for the 221 and 040 secondary reflections with the largest relative values of the amplitude *W* (see a partial list in Table 3 in §A3).

4. Graphical indexing of Renninger scans

With a list of susceptible phases in hand, another very important step is to have an efficient method to select the most easy-to-measure MD cases capable of providing reliable phase information. A graphical indexing method based on two-dimensional representation of Bragg cones (BCs) is used here for the sake of clarity in the data analysis (§§6.1 and 6.2). For any reflection of diffraction vector \mathbf{Q} , its two-dimensional BC representation is given by the relationship

$$\cos(\varphi - \alpha_Q) = \frac{\sin \theta - \sin \omega \cos \gamma_Q}{\cos \omega \sin \gamma_Q}.$$
 (3)

 ω and φ are the instrumental angles describing the incident wavevector

$$\mathbf{k} = -\frac{2\pi}{\lambda}(\cos\omega\cos\varphi, \cos\omega\sin\varphi, \sin\omega) \tag{4}$$

on a sample xyz frame where z is along the azimuthal rotation axis (Domagała *et al.*, 2016). The α_Q and γ_Q angles are obtained by projecting the diffraction vector onto this crystal frame, *i.e.*



Figure 4

(a) Difference $\Delta \delta$ in structure factor phases regarding the proposed models, as detailed in the inset (NH3 $\rightarrow F_G$ and N3 $e \rightarrow F'_G$). X-rays of 10 keV. (b) Three-beam cases predicted to show opposite profile asymmetries on each model structure according to the criterion $\cos \Psi \cos \Psi' < 1$. G = 261 and $\Delta \Psi = \Psi' - \Psi$ (NH3 $\rightarrow \Psi$ and N3 $e \rightarrow \Psi'$). Limited to amplitude W > 5%. $d_{G,H}$ is the interplanar distance of Bragg planes.

$$\mathbf{Q} = |\mathbf{Q}|(\sin \gamma_O \cos \alpha_O, \sin \gamma_O \sin \alpha_O, \cos \gamma_O), \quad (5)$$

where $|\mathbf{Q}| = (4\pi/\lambda) \sin \theta$ and $\mathbf{k} \cdot \mathbf{Q} = -|\mathbf{Q}^2|/2$. Equation (3) provides two solutions for the azimuth φ as a function of the incidence angle ω . These solutions represent the two possible excitation geometries that are plotted as the out-in (blue) and in-out (red) BC lines in the ω - φ graphs, *e.g.* Fig. 1. Using lines of different colors to identify each one of these solutions is quite helpful since the observed profile asymmetries depend on both phase and excitation geometry, as summarized in Fig. 5. Another useful technique for graphically indexing Renninger scans is plotting BC lines with relative thickness. Here we use line thicknesses proportional to the amplitude W [equation (2)]. For instance, in the Renninger scan of reflection 261 in Fig. 1, the strongest peak has the thickest BC lines owing to secondary 221 reflection.

5. Experimental

Single crystals of D-alanine were grown by slow evaporation from supersaturated aqueous solutions: D-alanine powder (98% purity) diluted in distilled water, concentration of 0.25 g ml⁻¹, and pH between 6 and 6.5. The solution was kept at a constant temperature (296 K) in a beaker covered with a perforated plastic lid for a period of three weeks. Transparent single crystals showing well formed natural faces were obtained, such as the one used here with approximate dimensions of $4 \times 3 \times 10$ mm and the largest face corresponding to the (130) planes (§A2, Fig. 12). Lattice parameters a = 6.031 (3), b = 12.335 (5) and c = 5.781 (3) Å were determined by X-ray powder diffraction in another sample of the same batch, and they agree very well with the MD peak positions within an accuracy of 0.01° .

X-ray data acquisition was carried out at the Brazilian Synchrotron Light Laboratory (LNLS), beamline XRD2, and at the Diamond Light Source, UK, beamline I16, testing advantages and limitations of two possible procedures for



Figure 5

Criteria of L|H ($s \cos \Psi < 1$) and H|L ($s \cos \Psi > 1$) for profile asymmetry in three-beam diffraction with respect to the in–out (s = +1) or out–in (s = -1) geometry of excitation and interval of values of the triplet phase Ψ : cos $\Psi < 1$, quadrants 2 and 3 (top panels), or cos $\Psi > 1$, quadrants 1 and 4 (bottom panels).

measuring line profiles of MD peaks. In one procedure, both adjustment arcs of the goniometric head are used to physically align the primary diffraction vector with one rotation axis of the sample stage. Wide azimuthal scans are possible, although eventual corrections of the incidence angle are necessary depending on the residual misalignment between the diffraction vector and the rotation axis. This procedure is preferred in terms of accuracy in both line profile and position of the peaks (Freitas *et al.*, 2007), although after fixing the sample one is limited to reflections that can be aligned within the $\pm 20^{\circ}$ range of the adjustment arcs. The rotating crystal method for indexing and pre-alignment of accessible reflections has been used, as demonstrated in §A1.

In the other procedure, the azimuthal scans are performed by combining rotations of the diffractometer axes. This multiaxis goniometry is the standard procedure in single-crystal diffractometers. The sample is fixed at the holder within eye accuracy, and after two nonparallel reflections have been found, the crystal orientation matrix is built. With an appropriate script for azimuthal scanning, it is possible to inspect many primary reflections automatically. But, the number of accessible MD cases and the data accuracy depend on the angular range of combined rotations and the sphere of confusion of the used diffractometer.

Despite of the distinct instrumentations at the used beamlines, the energy and angular resolution were nearly the same: spectral width of 2×10^{-4} and beam divergence of 0.1 mrad. The brightness of the beam at I16 requires some attention to avoid fast radiation damage to fragile crystals stabilized by hydrogen bonds such as D-alanine. Exposure to the direct beam causes immediate damage, e.g. the streaks seen at the (130) surface in Fig. 12 (inset) ($\S A2$). The primary $26\overline{1}$ reflection was measured with the physical alignment procedure and X-rays of 10 keV, while the multi-axis goniometry procedure was used to measure a few MD cases with primaries 261 and 080, and X-rays of 8 keV. Only the primary 080 was measured in Laue transmission geometry regarding the entrance surface (130): all others in Bragg reflection geometry. The vertical scattering plane (σ polarization) was used in all measurements, where the asymmetry criteria in Fig. 5 apply for most MD cases. For other polarizations these criteria must be reviewed (Stetsko et al., 2000; Morelhão & Avanci, 2001; Morelhão & Kycia, 2002).

6. Results and discussion

Line profile asymmetries have been determined according to the value of

$$R_{\rm a} = 2(\Delta I_{\rm L} - \Delta I_{\rm R}) / (\min\{I_{\rm s}\})^{1/2}, \tag{6}$$

where

$$\Delta I_{\rm L} = \frac{1}{N_{\varphi_j < \varphi_0}} \sum_{\varphi_j < \varphi_0} [I_{\rm e}(\varphi_j) - I_{\rm s}(\varphi_j)] \tag{7}$$

and

Table 1

Theoretical triplet phases according to structure models NH3 (Ψ) and N3*e* (Ψ ') of D-alanine for a few secondary *H* reflections seen in Fig. 1.

Letters b/r stand for blue/red BC lines. Experimental peak asymmetries are given in terms of parameter R_a , equation (6). Relative amplitudes and positions are estimated by the W and φ_0 values, respectively.

Н	Ψ (°)	Ψ' (°)	W(%)	R _a		$arphi_0 (^\circ)$
37 5 r	65	104	6	2.2	(H L)	30.415
210b	-111	-74	9	2.2	(H L)	30.773
0 31 r	165	-158	29	-33.8	(L H)	31.341
110b	-3	31	16	_	_	31.341
$22\overline{1}r$	-98	-60	100	-12.6	(L H)	32.722
080b	69	106	7	_	_	32.722
$2\overline{23}r$	73	108	11	1.0	(H L)	34.527
$1\overline{32}r$	0	31	12	3.7	(H L)	34.863
3 90b	-111	-72	6	-	_	34.863
33 3 r	-116	-72	11	-1.1	(L H)	35.463
140b	100	143	38	32.8	(H L)	37.114
150b	-3	32	16	-11.5	(L H)	37.391

$$\Delta I_{\rm R} = \frac{1}{N_{\varphi_j > \varphi_0}} \sum_{\varphi_j > \varphi_0} [I_{\rm e}(\varphi_j) - I_{\rm s}(\varphi_j)]. \tag{8}$$

 $N_{\varphi_j < \varphi_0}$ and $N_{\varphi_j > \varphi_0}$ are the number of data points on the left and right side of the diffraction peak, respectively. $\Delta I_{L,R}$ stand for the mean intensity difference on each side of the peak, since

 $I_{\rm e}(\varphi_j)$ is the *j*th experimental data point and $I_{\rm s}(\varphi_j)$ is the corresponding point obtained by data fitting with a symmetric pseudo-Voight function, which also provides the peak center φ_0 . The asymmetric character of each intensity profile is therefore given as H|L when $R_{\rm a} \ge 1$ or L|H when $R_{\rm a} \le -1$. Diffraction peaks are considered symmetric, *i.e.* with an indistinguishable type of asymmetry, when $|R_{\rm a}| < 1$. A few examples of data fitting by symmetric line profile functions are shown in Fig. 6, and their corresponding triplet phase values are given in Table 1.

Compatibility analysis between experimental asymmetries and proposed models is carried out on the basis of a true/false test according to

$$s\cos(\Psi)R_{a}$$
 $\begin{cases} >1 \Rightarrow true \\ <1 \Rightarrow false \end{cases}$ (9)

which is reliable if $|R_a| \ge 1$. The true/false outcomes for each model are indicated by checkboxes beside each experimental profile in Fig. 6. Even profile asymmetries in the symmetric/ asymmetric limit where $|R_a| \ge 1$ can be classified within eye accuracy, such as those at $\varphi_0 = 34.53^{\circ}$ ($R_a = 1$) and $\varphi_0 = 35.46^{\circ}$ ($R_a = -1.1$). In all cases, the profile asymmetries are consistent (true) for the NH3 model only.



Figure 6

Analysis of MD peak-profile asymmetry in D-alanine. Experimental profiles (closed circles connected by lines) from Fig. 1 shown against data fitting with a symmetrical function (dashed red lines). Primary reflection $G = 26\overline{1}$. *H* reflections (blue/red indexes for out–in/in–out geometries), triplet phase values for both model structures (arrows) and their compatibility (checkbox) with the observed profile asymmetries (R_a values at left) are indicated for each peak, as well as in Table 1.

Let us emphasize what has been accomplished so far. By selecting just a few MD cases (Fig. 6) within a narrow Renninger scan of no more than 10°, we already demonstrate experimentally the existence of a non-spherosymmetric electron density due to H atoms around the amine group. This is an impressive result with respect to the current methods in crystallography where, to perform a similar demonstration, it would be necessary to collect thousands of reflections and solve the phase problem for constructing high-resolution electron density maps of the amine group as done by Gopalan et al. (2000), or to combine diffraction data and calculations of periodic density functional theory as done by Funnell et al. (2010). However, more refined models than NH3 are needed to explain intermolecular forces stabilizing the crystal structure, which would not exist if all atoms are neutral and unpolarized.

6.1. Model structure refinement

Being able to discriminate between model structures with subtle differences is the actual challenge to phase measurements. Detecting small shifts in the triplet phases involves working with nearly symmetrical profiles whose asymmetric character can be influenced by nearby MD cases. Therefore, identification of isolated MDs is a crucial step in testing the compatibility between structure models and profile asymmetries. Coincident BC lines of comparable strength (*W* value) crossing the primary BC line at close positions can compromise the asymmetry analysis, as shown for example in Fig. 7. When the instrumentation allows the measurement of both out-in and in-out excitation geometries, as in a complete Renninger scan ((A2), both profiles must present opposite asymmetries. Otherwise, only the one with an isolated BC line or with very weak neighbors can be used, as in Fig. 7(*b*).

More refined models are obtained by taking into account small variations in ionic charges. To investigate the polarization of hydrogen bonds, the atomic scattering factors for the amine group are written as $f_{N^{3x-}} = (1-x)f_N + xf_{N^{3-}}$ for the nitrogen and $f_{H^{x+}} = (1-x)f_H$ for the hydrogen atoms. x = 0and x = 1 are the two extreme situations represented in the NH3 and N3e models, respectively. Phase measurements agree with theoretical phases for x = 0. However, by slightly changing x we can have a more accurate idea of how susceptible the phases actually are to electron charge distribution at the amine group.

For x = 0.1, shifts in triplet phases of about $\Delta \Psi = \pm 4^{\circ}$ would be enough to invert the line profile asymmetry of a few MD peaks of reasonable amplitudes W > 5%; they are indicated as the most susceptible cases in Table 3 (§A3). Experimentally we are limited to the peaks with an isolated BC line and a reliable value of asymmetry ($|R_a| \ge 1$) that are shown in Fig. 8. Their asymmetries are consistent with the NH3 model where x < 0.1, which means that H atoms in the amine group are practically neutral atoms with effective ionic charges smaller than +0.1e.

The compatibility of other models has also been verified. Consider, for instance, a model with one electron removed from the N and shared between the O atoms. The atomic scattering factors are for the nitrogen N^+ and oxygen $O^{0.5-}$ ions, while all other atoms are neutral. When compared to the



Figure 7

(a) Out-in and (b) in-out experimental profiles of an MD case. The H|L asymmetry in (a) is caused by the nearby $44\overline{2}$ BC line. R_a values are shown below the true/false checkbox for compatible asymmetry with the NH3 model. Horizontal dashed lines denote the 261 BC line.





Experimental profiles and respective $\omega - \varphi$ graphs of the most susceptible cases for polarization of hydrogen bonds. $R_{\rm a}$ values are shown below the true/false checkbox for compatible asymmetry with the NH3 model. Horizontal dashed lines denote the 261 BC line.

Table 2

MD cases where $\cos\Psi\cos\Psi''<0$ for D-alanine NH3 (Ψ) and zwitterion (Ψ'') models.

Secondary *H* reflections diffracting at azimuth φ_{oi} (out–in) and φ_{io} (in–out). Primary reflection $G = 26\overline{1}$. X-rays of 10 keV.

Н	$\Psi\left(^{\circ} ight)$	$\Psi^{\prime\prime}$ (°)	$W\left(\% ight)$	$arphi_{ m oi}$ (°)	$arphi_{ m io}$ (°)
$\overline{1}2\overline{2}$	-88.8	-90.7	18	314.258	116.679
341	-88.8	-90.7	18	134.258	296.679
471	91.3	89.9	8	47.780	157.278
612	91.3	89.9	8	227.780	337.278
$\overline{1}2\overline{3}$	90.9	88.6	8	310.281	100.009
342	90.9	88.6	8	130.281	280.009
342	90.9	89.0	6	232.542	5.367
$\overline{1}101$	90.9	89.0	6	52.542	185.367

NH3 model, the MD peaks that could present inversion of asymmetry are exactly the same ones previously analyzed in Fig. 8. Then, there is no evidence that the electron from the amine group is evenly shared between the two O atoms of the carboxylate group.

A zwitterion model where the electron from the N⁺ ion is placed at the nearest oxygen O⁻ ion, as indicated in Fig. 1 (inset), seems to be compatible with the data. The discrepancies in comparison to the NH3 model are listed in Table 2 and the MD peaks of this list that could be measured are shown in Fig. 9. The phase shifts are very small and can affect only MD cases with Ψ very close to $\pm 90^{\circ}$, whose asymmetric character is difficult to identify. Although, the four profiles agree with the zwitterion model, the most reliable profile is the one in Fig. 9(c), where there are no nearby BC lines and the asymmetric parameter value $R_a = 0.9$ is close to the detectability limit of asymmetry established in equation (6).

6.2. Radiation damage

The possibility of studying radiation damage of hydrogen bonds arises because of the high sensitivity of triplet phases to the presence of these bonds. Assuming the zwitterion model $(NH_3^+-C_2H_4-COO^-)$ with x as the occupancy of H sites at N-H···O bonds, the MD case with $H = \overline{150}$ (Fig. 8a) has triplet phase $\Psi = -87.4^\circ$ for x = 1 and $\Psi = -93.6^\circ$ for x = 3/4 when calculated for X-rays of 8 keV. These phase values mean that phase measurements can detect one missing H atom on every four bonds or, equivalently, an average of three broken bonds per unit cell (Fig. 2c).

Direct radiation damage of hydrogen bonds can be caused by Compton scattering, whose cross section for H atoms is 0.5748×10^{-22} mm². To have one H⁺ ion on every four H atoms within a time scale of 10 h - a typical single-crystal experiment – the required beam flux is $1.2 \times$ 10^{17} ph mm⁻² s⁻¹, too high a value for today's synchrotron sources. However, broken hydrogen bonds as secondary damage caused by collision of any ejected electrons from other atoms demand a much lower flux. The ionization cross section for the entire unit cell of D-alanine is $3962 \times$ 10⁻²² mm² when taking into account Compton and photoelectric processes (see A3). Then, three ionizations per unit cell in a time period of 10 h require a flux of $2.1 \times$ 10^{14} ph mm⁻² s⁻¹. On a beam size of 50×200 µm, this flux corresponds to an intensity of 2.1×10^{12} ph s⁻¹, well below the direct beam intensity of 10^{13} ph s⁻¹ available at the I16 beamline of the Diamond Light Source. The visible damage observed after a few seconds of exposure to such a direct beam (Fig. 12 inset, $\S A2$) can be understood if each ejected electron is capable of destroying not only one but many hydrogen bonds. When the hydrogen electron is ejected either by



Figure 9

Experimental profiles and respective $\omega - \varphi$ graphs of the most susceptible cases to the zwitterion model. R_a values are shown below the true/false checkbox for compatible asymmetry with the NH3 model. Horizontal dashed lines denote the 261 BC line.



Figure 10

Experimental profiles and respective $\omega - \varphi$ graphs of a few MD peaks measured using multi-axis goniometry for primary (a), (c) 261 and (b), (d) 080 reflections. R_a values are shown below the true/false checkbox for compatible asymmetry with the NH3 model.

Compton or electron collision, the H^+ ion is repelled by the N^+ ion, preventing any fast mechanism of electron-hole pair recombination to repair the missing bond. Formation of H_2 gas has been reported instead (Meents *et al.*, 2010).

With the multi-axis goniometry of beamline I16, short azimuthal scans could be performed on a few MD cases, including cases on other primary reflections. Most of the profiles agree with the zwitterion model, such as those in Figs. 10(a) and 10(b). But, there were two exceptions that are shown in Figs. 10(c) and 10(d). The MD with primary reflection 261 and secondary reflection $\overline{150}$ has a triplet phase very susceptible to the presence of hydrogen bonds, as discussed above. Its asymmetry, seen in Fig. 10(c), is clearly of the L|H type, opposite to that seen in Fig. 8(a), indicating a phase shift towards a final value of $\Psi < -90^{\circ}$. This shift can be explained on the basis of radiation damage when more than 25% of the intermolecular bonds have been broken during data acquisition. The direct beam was attenuated enough to avoid fast degradation of the sample due to damage on macroscopic scales that could be perceived under an optical microscope after hours of exposure. The theoretical ionization rate for such a high-intensity beam and observed phase shift are in agreement. Nevertheless, both results (theoretical and experimental) should be taken just as evidence suggesting that phase measurements are a feasible method to quantify radiation damage at the atomic level on biological single crystals. Further investigations under more controlled conditions of flux and time of exposure are still needed to delimit adequate instrumentation and procedures for this type of study.

Profile asymmetries with the primary 080 reflection are not susceptible to the subtle variations of model structures

discussed in this work. All MD cases for this primary reflection should present asymmetries according to the zwitterion model. This allows us to search for MD cases that are exceptions to the asymmetry rule in Fig. 5. Although the 080 reflection diffracts under Laue transmission geometry, i.e. the incident and reflected beams are not on the same side of the (130) crystal surface, the only rule exception we found, shown in Fig. 10(d), has poor sensitivity to the triplet phase owing to polarization suppression of the second-order term of dynamical coupling responsible for the phase information (Thorkildsen & Larsen, 1998; Stetsko et al., 2000; Morelhão & Kycia, 2002). This situation occurs when the H reflection has a Bragg angle close to 45°, such as the 125 reflection (Bragg angle of 43.9°), and diffracts in π polarization, *i.e.* its BC line appears nearly vertical in the ω - φ graph for the used beamline setup. Another situation compromising direct phase evaluation occurs for MD cases with very weak Umweganregung and strong Aufhellung components (Weckert & Hümmer, 1997; Rossmanith, 1999). Such cases are easily avoided when a very weak reflection can be chosen as the primary reflection. Otherwise, MD cases with very weak or polarization suppressed G-H coupling reflections have poor reliability for phase measurements.

7. Conclusions

The main achievement of this work is to have demonstrated in practice the full potential of phase measurements applied to current trends in crystallography. Hydrogen bonds were easily detected, a maximum value attributed to their effective polarization, model structures with subtle variations in ionic charges discriminated, relevant information for molecular dynamics studies of this amino acid crystal obtained, and insights on quantitative analysis of radiation damage discussed on theoretical and experimental grounds. Besides a model where all atoms are neutral, the only other model that can agree with the whole data set of MD profile asymmetries is the zwitterion model where an electron from the nitrogen orbitals goes to the nearest oxygen atom. In this case, the O atoms in the carboxylate group have different ionic charges and the intermolecular forces stabilizing the D-alanine crystal are also van der Waals forces between $N^+ \rightarrow O^-$ electrical dipoles. Phase sensitivity to the average number of hydrogen bonds per unit cell and experiments using high-flux synchrotron radiation point towards a damage mechanism where most of the bond cleavage is caused by photoelectron collisions. A whole package of experimental and data analysis procedures are given and explained in detail, allowing immediate use of phase measurement on a wide range of studies. The only requirements are crystals of good quality capable of undergoing dynamical diffraction and the availability of suitable structure models for each specific feature in the crystal electron density to be investigated.

APPENDIX A

A1. Physical alignment of primary reflection by using the rotating crystal method

With an area detector (the Pilatus 100K in our case) attached to the 2θ arm of the single-crystal diffractometer,



Figure 11

(a) Diffraction spots on the detector area collected in a 360° spin of the sample around the diffraction vector of reflection 261. Sample–detector distance is 74.7 mm. X-rays of 10 keV, σ polarization. (b) Indexing of diffraction spots by simulation of the rotating crystal method [using the simulation routine in Appendix B of Morelhão (2016)]. Area detector width in horizontal direction.

two-dimensional array indices $m_c n_c$ of the reference pixel receiving most of the direct beam $(2\theta = 0)$ are identified. After fixing the sample in a goniometer head that has arcs for orientation correction, placing the area detector at a distance D from the sample, and moving the detector arm to a desired 2θ value, the φ axis is spun by 360° while the detector acquires images at the rate of one frame per degree of rotation. Diffraction spots at pixels of indices mn correspond to reflections with scattering angles $2\theta_{mn} = \cos^{-1}(\hat{R} \cdot \hat{z})$, where $\mathbf{R} = |\mathbf{R}|\hat{R} = \mathbf{R}_c + \mathbf{r}_d$, $\mathbf{R}_c = D[\sin(2\theta)\hat{x} + \cos(2\theta)\hat{z}]$, $\mathbf{r}_d = -(n - n_c)p\hat{x}_d + (m - m_c)p\hat{y}_d$, $\hat{x}_d = \cos(2\theta)\hat{x} - \sin(2\theta)\hat{z}$ and $\hat{y}_d = \hat{y}$. In the laboratory frame, \hat{z} is along the direct beam, \hat{x} is vertical and \hat{y} is horizontal. The pixel size for the used detector is p = 0.172 mm.

A diffraction spot with scattering angle close to that of the desired primary reflection is selected and aligned to the φ axis. By using as input pixel indices *mn* and azimuth φ_{mn} of a spot, a script suitable for the used diffractometer was written to provide the values by which each arc has to be corrected. A new spin of the rotation axis is then carried out to confirm that the aligned reflection is in fact the desired one, as shown in Fig. 11 for the 261 reflection.

A2. Azimuthal scanning with a single goniometer axis

The full Renninger scan of the $26\overline{1}$ reflection shown in Fig. 12 is composed of 72 uninterrupted φ scans. At the first point of each scan, the primary reflection has been centered at its rocking curve (FWHM of 0.07 mrad). The maximum drift of the rocking curve's center as a function of φ was 0.2 mrad. In Fig. 12, smooth variations of the baseline intensity have been flattened for the sake of visualization of the 180° symmetry of the data, although the peak intensities are





Complete Renninger scan of reflection $26\overline{1}$ in polar plot: $x = -\log(I/I_{\text{max}})\cos\varphi$ and $y = -\log(I/I_{\text{max}})\sin\varphi$. $I_{\text{max}} = 1.8 \times 10^5$ counts per 0.1 s. X-rays of 10 keV, σ polarization. Reference direction ($\varphi = 0$): *c* axis in the incident plane pointing downstream. Sense of sample rotation: clockwise with the diffraction vector pointing to the observer. Inset: used sample showing streaks on face (130) caused by the direct beam.

Table 3 Partial list of MD cases in which $\cos \Psi \cos \Psi' < 0$ regarding the NH3 (Ψ) and N3e (Ψ') structure models of D-alanine.

Secondary *H* reflections diffracting at azimuth φ_{oi} (out-in) and φ_{io} (in-out). Primary reflection $G = 26\overline{1}$. X-rays of 10 keV.

Н	Ψ (°)	Ψ' (°)	$W\left(\% ight)$	$arphi_{ m oi}$ (°)	$arphi_{ m io}$ (°)
040	-98.1	-60.4	100	12.199	212.730
221	-98.1	-60.4	100	192.199	32.730
131	72.9	111.1	31	45.132	206.099
332	72.9	111.1	31	225.132	26.099
110	-102.3	-65.4	29	130.286	357.040
151	-102.3	-65.4	29	310.286	177.040
220	75.0	112.3	28	143.710	343.615
$04\overline{1}$	75.0	112.3	28	323.710	163.615
012	-116.0	-79.5	25	98.710	246.456
253	-116.0	-79.5	25	278.710	66.456
122	79.9	112.8	23	151.438	279.499
183	79.9	112.8	23	331.438	99.499
$2\overline{2}0$	75.3	112.5	23	188.775	346.556
081	75.3	112.5	23	8.775	166.556
122	79.0	118.0	23	249.286	43.466
181	79.0	118.0	23	69.286	223.466
150†	89.8	125.5	19	15.689	185.424
311†	89.8	125.5	19	195.689	5.424
$2\overline{6}0$	75.5	112.7	19	221.416	331.212
$012\overline{1}$	75.5	112.7	19	41.416	151.212
020	79.1	118.8	18	1.584	223.346
241	79.1	118.8	18	181.584	43.346
113†	89.7	130.9	17	306.476	93.272
352†	89.7	130.9	17	126.476	273.272
223	73.1	107.5	17	126.720	267.779
$04\overline{4}$	73.1	107.5	17	306.720	87.779
221	-111.9	-75.2	17	126.354	304.583
$04\overline{2}$	-111.9	-75.2	17	306.354	124.583
$22\overline{3}$	-102.6	-62.6	16	256.833	54.872
042	-102.6	-62.6	16	76.833	234.872
151	78.0	114.8	14	333.637	351.023
3110	78.0	114.8	14	153.637	171.023
241	71.4	106.1	13	108.155	286.344
$02\overline{2}$	71.4	106.1	13	288.155	106.344
391	62.4	100.2	13	23.392	146.181
530	62.4	100.2	13	203.392	326.181
$0\overline{4}3$	71.8	109.0	13	178.286	228.492
$210\overline{4}$	71.8	109.0	13	358.286	48.492
$2\overline{23}$	73.2	107.7	11	251.254	34.538
333	-115.7	-71.6	11	250.307	35.484
303†	88.9	125.2	10	150.154	280.783
164†	88.9	125.2	10	330.154	100.783
$\overline{210}$	-111.1	-73.8	9	30.734	114.471
105†	88.9	125.3	8	288.312	52.335
164†	88.9	125.3	8	108.312	232.335
080†	68.5	105.5	7	32.730	192.199
293†	-91.1	-54.0	7	272.849	351.002
0152†	-91.1	-54.0	7	92.849	171.002
390	-111.3	-72.4	6	34.859	157.769
375	64.5	103.9	6	312.753	30.450

† Susceptible cases to polarization of hydrogen bonds.

different since the (130) entrance surface normal direction is not the one aligned to the rotation axis.

A3. Calculation codes for triplet phases and ionization cross sections

Structure factors taking into account non-resonant and resonant terms of the atomic scattering factors were calculated by the routine sfactor.m. It lists the structure factors used for comparison of phase values, as in Fig. 4 and Tables 1, 2 and 3. This routine can be found in open codes on the internet (Morelhão, 2016), as can the routines sgcompton.m and fpfpp.m used for calculating the Compton and photoelectric absorption cross sections, respectively.

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